

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/808,133	IWAI	
Examiner	Art Unit	
Jade O. Laye	2614	

SEARCHED					
Class	Subclass	Date	Examiner		
725	58	2/9/2005	JL		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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	Subclass	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
consulted with Scott Beliveau	2/9/2005	JL		
Text search following 725 subclass: 102,110,131,134,136,139,142	3/4/2005	JL		
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